AMENDMENTS TO THE SPECIFICATION:

Please amend Table 3 at page 32, as follows:

| | | | /- · · · · · · · · | | | | | | |
|--|-------------------|---------------------------------|-----------------------|---------------------------------------|-----------------------|-----------------------|----------------------------------|----------------------------------|-----------------------------------|
| | • | Comparative | Comparative | Comparative | Comparative | Comparative | Comparative | Comparative | Comparative |
| | ī | Example 1 | Example 2 | Example 3 | Example 4 | Example 5 | Example 6 | Example 7 | Example 8 |
| Construction of Adhesive Film | Base Film | PET | PET | PET | PP | EVA | PET | PET | Thermoplastic Pl |
| | Thickness (µm) | 100 | 6 | 250 | 100 | 120 | 50 | 50 | 50 |
| | Melting Paint (℃) | 255 | 255 | 255 | 160 | 85 | 255 | 255 | 200 or more |
| | Main Agent | 2 | 1 | 1 | 1 | 1 | 3 | 3 | _ |
| | Coating Solution | 2 | 1 | 1 | 1 | 1 | 3 | 3 | - |
| | Adhesive Film | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 |
| Thickness of Adhesive Layer (дл.) | | 10 | 10 | 10 | 10 | 10 | 10 | 120 | |
| Adhesive Force (g/25mm) | | 70 | 330 | 8 | 80 | 120 | 40 , | 220 | |
| : | | | | | _ | Ì | 1.2×10^4 | | 3.0x10 ⁹ |
| Elastic Modulus (Pa) | | 0.5 x 10 ⁵ | 1.5 x 10 ⁵ | 1.5 x 10 ⁵ | 1.5 x 10 ⁵ | 1.5 x 10 ⁵ | 1.5 x 10 ⁵ | 1.5×10^{5} | 3.0 x 10 ⁵ |
| Back Grinding | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Back Processing | Chemical Etching | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | Polishing | 0 | 0 | x | 0 | 0 | 0 | 0 | 0 |
| | Plasma Etching | 0 | 0 | x | х | x | 0 | 0 | 0 |
| Contamination after Back Grinding and Chemical Etching | | 0 | Bad peeling | penetration of etching solution | 0 | 0 | 6 wafers: adhesive residue | 1 wafer: adhesive residue | 10 wafers: adhesive residue |
| Contamination after Back Grinding and Polishing | | 0 | Bad peeling | penetration of polishing agent | 0 | 0 | adhesive residue | Bad peeling | 10 wafers: adhesive residue |
| Contamination after Back Grinding and Plasma Etching | | 4 wafers adhesive residue | Bad peeling | Plasma error | Film deformed | Film deformed | 8 wafers: adhesive residue | 5 wafers: adhesive residue | 10 wafers: adhesive residue |
| Wafer Breakage after Back Grinding and Chemical Etching | | 0 | 0 | - | 0 | 0 | 0 | 0 | 5 wafers broken |
| Wafer Breakage after Back Grinding and Polishing | | 0 | 0 | - | 0 | 0 | 0 | 0 | 8 wafers broken |
| Wafer Breakage after Back Grinding and Plasma Etching | | 0 | 0 | _ | 2 wafers cracked | 6 wafers cracked | 0 | 0 | 6 wafers broken |